

AOD518/AOI518

30V N-Channel AlphaMOS

General Description

- Latest Trench Power MOSFET technology
- Very Low RDS(on) at 10VGS
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

Product Summary

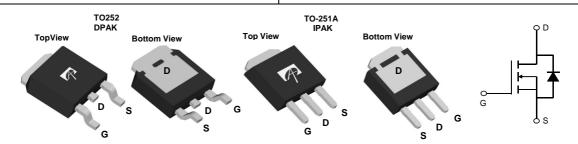
 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 54A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 8m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 12m\Omega \end{array}$

100% UIS Tested 100% R_g Tested



Application

- DC/DC Converters in Computing
- Isolated DC/DC Converters in Telecom and Industrial



Absolute Maximum Ratings T _A =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V_{GS}	±20	V			
Continuous Drain	T _C =25℃		54				
Current ^G	T _C =100℃	I _D	42	A			
Pulsed Drain Current ^C		I _{DM}	96				
Continuous Drain	T _A =25℃		15	A			
Current	T _A =70℃	IDSM	12	<u> </u>			
Avalanche Current ^C		I _{AS}	25	A			
Avalanche energy L=0.1mH ^C		E _{AS}	31	mJ			
V _{DS} Spike	100ns	V _{SPIKE}	36	V			
	T _C =25℃	P _D	50	W			
Power Dissipation ^B	T _C =100℃	- D	25	VV			
	T _A =25℃	В	2.5	W			
Power Dissipation A	T _A =70℃	P _{DSM}	1.6	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s Steady-State R _{θJA}		16	20	€/M			
Maximum Junction-to-Ambient AD			41	50	℃/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	2.5	3	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V	T,=55℃			1 5	μΑ		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±20V	. J			100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA		1.8	2.2	2.6	V		
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A			6	8	0		
			T _J =125℃		7.5	10	mΩ		
		V _{GS} =4.5V, I _D =20A			8.5	12	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A			91		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V		
Is	Maximum Body-Diode Continuous Current ^G					54	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			951		pF		
C _{oss}	Output Capacitance				373		pF		
C _{rss}	Reverse Transfer Capacitance				62		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.7	1.5	2.3	Ω		
SWITCHII	NG PARAMETERS								
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A			15.7	22.5	nC		
Q _g (4.5V)	Total Gate Charge				7.5	10.5	nC		
Q_{gs}	Gate Source Charge				2.8		nC		
Q_{gd}	Gate Drain Charge				3.2		nC		
t _{D(on)}	Turn-On DelayTime				6.25		ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =0.75 Ω , R_{GEN} =3 Ω			2.5		ns		
t _{D(off)}	Turn-Off DelayTime				18.5		ns		
t _f	Turn-Off Fall Time				4		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			10.2		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	se Recovery Charge I _F =20A, dI/dt=500A/μs			13.6		nC		

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{θJA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175 $^\circ$ C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $\overset{\leftarrow}{T}_{J(MAX)}\!\!=\!\!175^\circ\,$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175 $^{\circ}$ C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

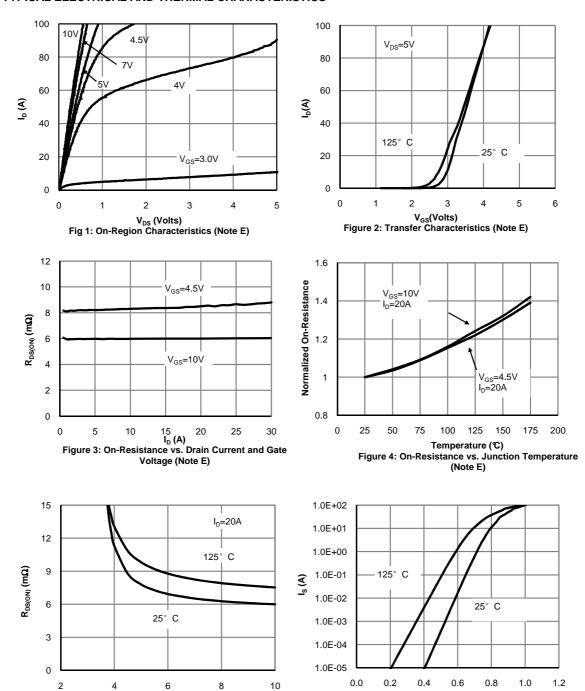
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

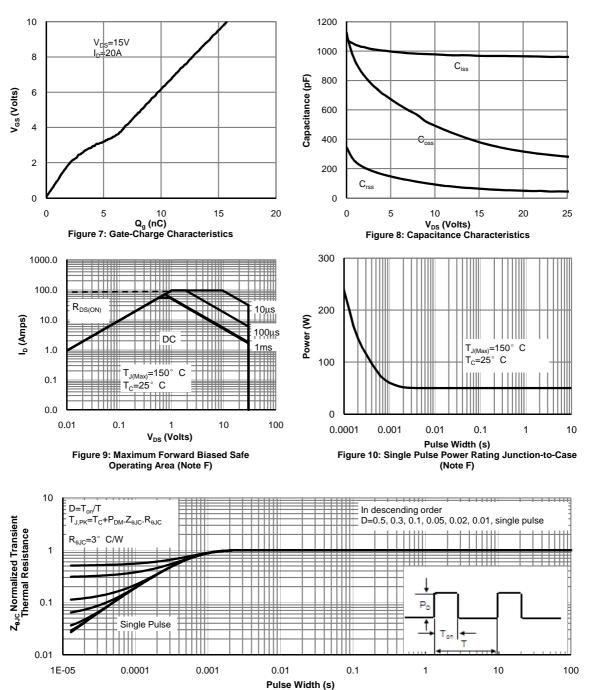
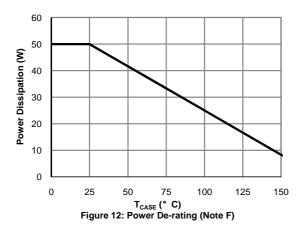


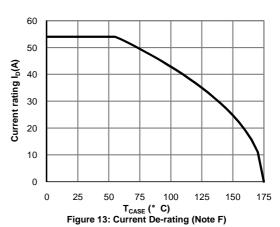
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

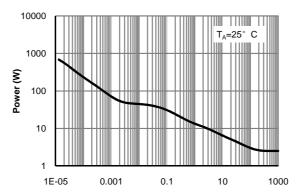
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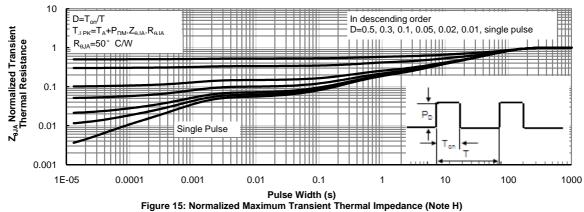
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS







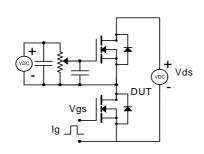
Pulse Width (s) Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

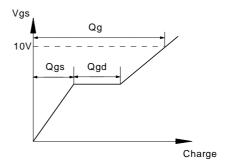


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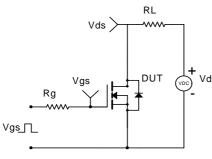


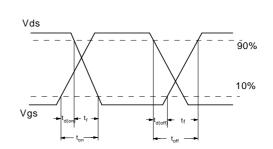
Gate Charge Test Circuit & Waveform



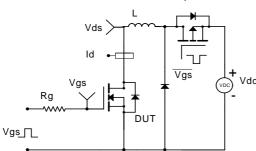


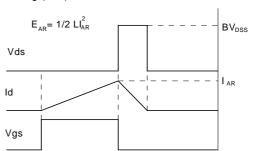
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

